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Application/Control No.	Applicant(s)/Patent under Reexamination		
10/726,945	PEREZ ET AL.		
Examiner	Art Unit		
Chun-Kuan (Mike) Lee	2181		

SEARCHED				
Class	Subclass	Date	Examiner	
710	3	4/3/2006	ctun- Kuan Lee	
710	36	4/3/2006		
710	62	4/3/2006	V	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
(EAST) US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB Google Inventor search utilizing Palm and East	4/3/2006	CHOY- KUAY Lee,		